

BLF147 VHF power MOS transistor Rev. 06 — 5 December 2006

Product data sheet

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NXP Semiconductors



FEATURES

- High power gain
- Low intermodulation distortion
- · Easy power control
- Good thermal stability
- Withstands full load mismatch.

APPLICATIONS

• Industrial and military applications in the HF/VHF frequency range.

DESCRIPTION

Silicon N-channel enhancement mode vertical D-MOS transistor encapsulated in a 4-lead, SOT121B flange package with a ceramic cap. All leads are isolated from the flange. A marking code, showing gate-source voltage (V_{GS}) information is provided for matched pair applications. Refer to the "General" section of the handbook for further information.

CAUTION

This product is supplied in anti-static packing to prevent damage caused by electrostatic discharge during transport and handling. For further information, refer to Philips specs.: SNW-EQ-608, SNW-FQ-302A, and SNW-FQ-302B.

QUICK REFERENCE DATA

RF performance at T_h = 25 °C in a common source test circuit.

MODE OF OPERATION	f (MHz)	V _{DS} (V)	P _L (W)	G _p (dB)	η _D (%)	d ₃ (dB)	d ₅ (dB)
SSB, class-AB	28	28	150 (PEP)	>17	>35	<-30	<-30
CW, class-B	108	28	150	typ. 14	typ. 70	_	_

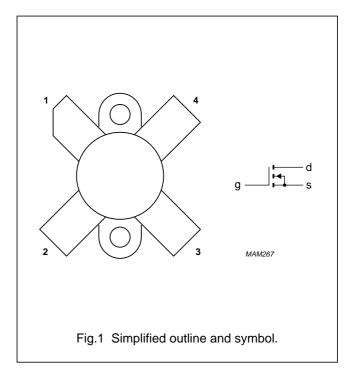
WARNING

Product and environmental safety - toxic materials

This product contains beryllium oxide. The product is entirely safe provided that the BeO disc is not damaged. All persons who handle, use or dispose of this product should be aware of its nature and of the necessary safety precautions. After use, dispose of as chemical or special waste according to the regulations applying at the location of the user. It must never be thrown out with the general or domestic waste.

PINNING - SOT121B

PIN	DESCRIPTION
1	drain
2	source
3	gate
4	source



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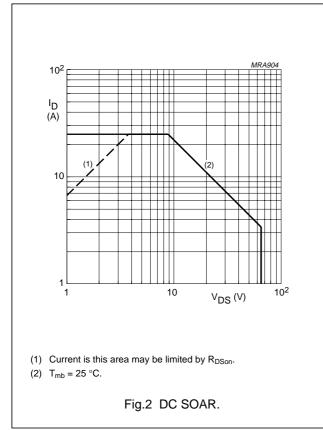
LIMITING VALUES

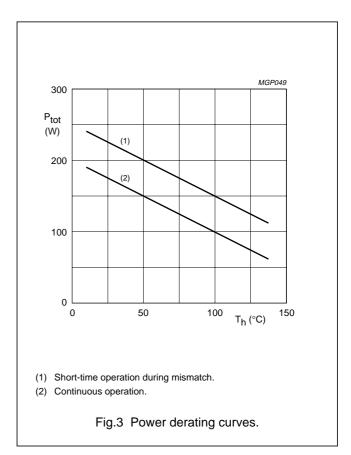
In accordance with the Absolute Maximum System (IEC 60134).

SYMBOL	PARAMETER	CONDITIONS	MIN.	MAX.	UNIT
V _{DS}	drain-source voltage		_	65	V
V _{GS}	gate-source voltage		-	±20	V
I _D	drain current (DC)		-	25	А
P _{tot}	total power dissipation	$T_{mb} \le 25 \ ^{\circ}C$	_	220	W
T _{stg}	storage temperature		-65	150	°C
Tj	junction temperature		-	200	°C

THERMAL CHARACTERISTICS

SYMBOL	PARAMETER	VALUE	UNIT
R _{th j-mb}	thermal resistance from junction to mounting base	0.8	K/W
R _{th mb-h}	thermal resistance from mounting base to heatsink	0.2	K/W





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CHARACTERISTICS

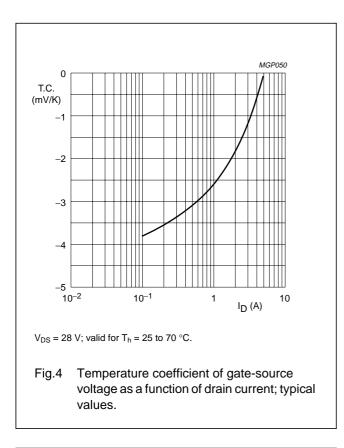
 $T_i = 25 \ ^{\circ}C$ unless otherwise specified.

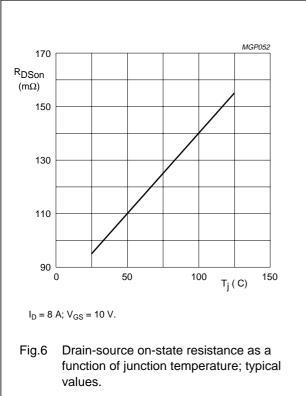
SYMBOL	PARAMETER	CONDITIONS	MIN.	TYP.	MAX.	UNIT
V _{(BR)DSS}	drain-source breakdown voltage	I _D = 100 mA; V _{GS} = 0	65	-	-	V
I _{DSS}	drain-source leakage current	$V_{GS} = 0; V_{DS} = 28 V$	_	-	5	mA
I _{GSS}	gate-source leakage current	$V_{GS} = \pm 20 \text{ V}; V_{DS} = 0$	-	-	1	μA
V _{GSth}	gate-source threshold voltage	I _D = 200 mA; V _{DS} = 10 V	2	-	4.5	V
ΔV_{GS}	gate-source voltage difference of matched pairs	I _D = 100 mA; V _{DS} = 10 V	-	-	100	mV
g fs	forward transconductance	I _D = 8 A; V _{DS} = 10 V	5	7.5	-	S
R _{DSon}	drain-source on-state resistance	I _D = 8 A; V _{GS} = 10 V	-	0.1	0.15	Ω
I _{DSX}	on-state drain current	V _{GS} = 10 V; V _{DS} = 10 V	-	37	-	А
C _{is}	input capacitance	V _{GS} = 0; V _{DS} = 28 V; f = 1 MHz	_	450	-	pF
C _{os}	output capacitance	V _{GS} = 0; V _{DS} = 28 V; f = 1 MHz	_	360	-	pF
C _{rs}	feedback capacitance	$V_{GS} = 0; V_{DS} = 28 V; f = 1 MHz$	-	55	-	pF

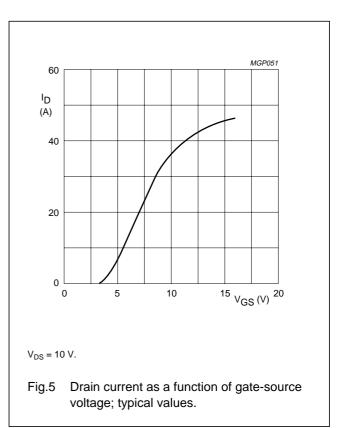
V_{GS} group indicator

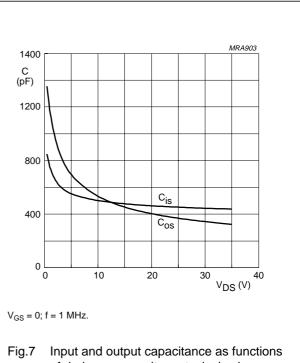
GROUP		ITS /)	GROUP		NITS V)
	MIN.	MAX.		MIN.	MAX.
А	2.0	2.1	0	3.3	3.4
В	2.1	2.2	Р	3.4	3.5
С	2.2	2.3	Q	3.5	3.6
D	2.3	2.4	R	3.6	3.7
E	2.4	2.5	S	3.7	3.8
F	2.5	2.6	Т	3.8	3.9
G	2.6	2.7	U	3.9	4.0
Н	2.7	2.8	V	4.0	4.1
J	2.8	2.9	W	4.1	4.2
К	2.9	3.0	Х	4.2	4.3
L	3.0	3.1	Y	4.3	4.4
М	3.1	3.2	Z	4.4	4.5
Ν	3.2	3.3			

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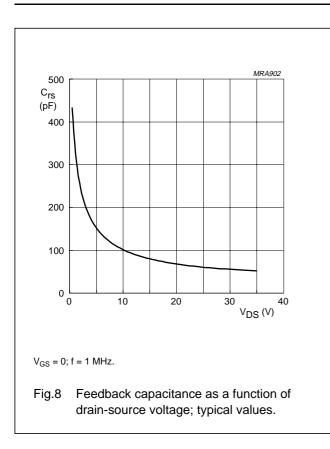






Ig.7 Input and output capacitance as function of drain-source voltage; typical values.

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APPLICATION INFORMATION FOR CLASS-AB OPERATION

RF performance in SSB operation in a common source class-AB circuit.

 $T_{h} = 25 \text{ °C}; \text{ } \text{R}_{th \text{ mb-}h} = 0.2 \text{ K/W}; \text{ } \text{R}_{GS} = 9.8 \text{ } \Omega; \text{ } \text{f}_{1} = 28.000 \text{ MHz}; \text{ } \text{f}_{2} = 28.001 \text{ MHz}; \text{ unless otherwise specified}.$

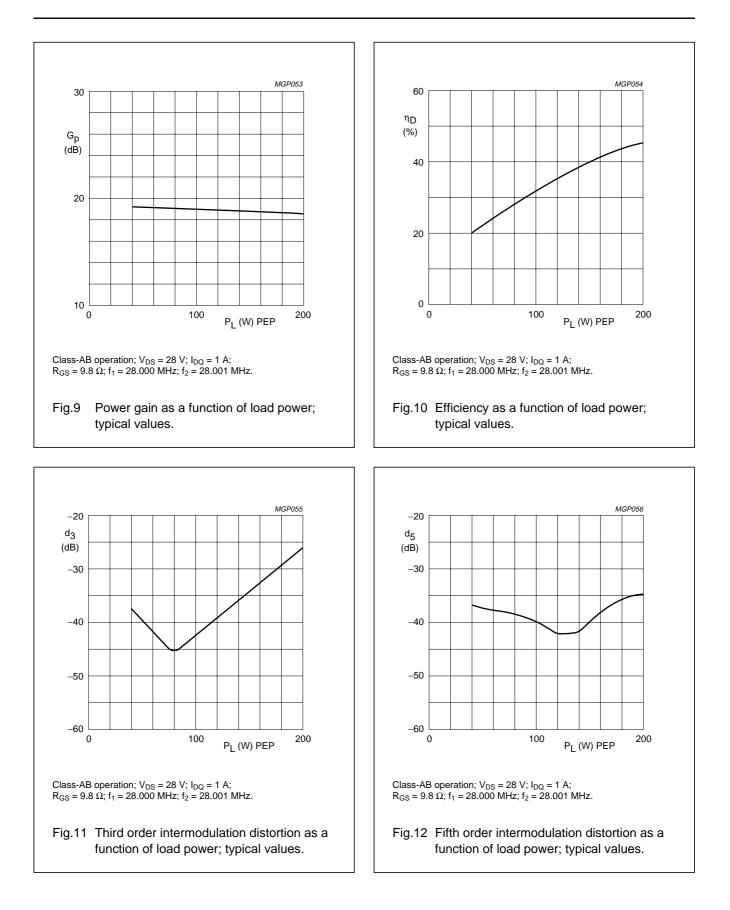
P _L (W)	f (MHz)	V _{DS} (V)	І _{DQ} (А)	G _p (dB)	η _D (%)	d ₃ (dB) (note 2)	d ₅ (dB) (note 2)
20 to 150 (PEP)	28	28	1	>17 typ. 19	>35 typ. 40	<–30 typ. –34	<-30 typ40

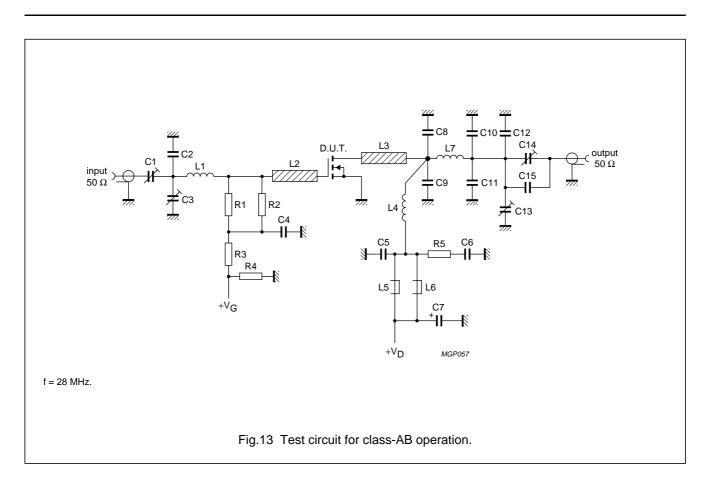
Notes

- 1. Optimum load impedance: $2.1 + j0 \Omega$.
- 2. Maximum values at drive levels within the specified PEP values for either amplified tone. For the peak envelope power the values should be decreased by 6 dB.

Ruggedness in class-AB operation

The BLF147 is capable of withstanding a load mismatch corresponding to VSWR = 50:1 through all phases under the following conditions: $V_{DS} = 28$ V; f = 28 MHz at rated load power.





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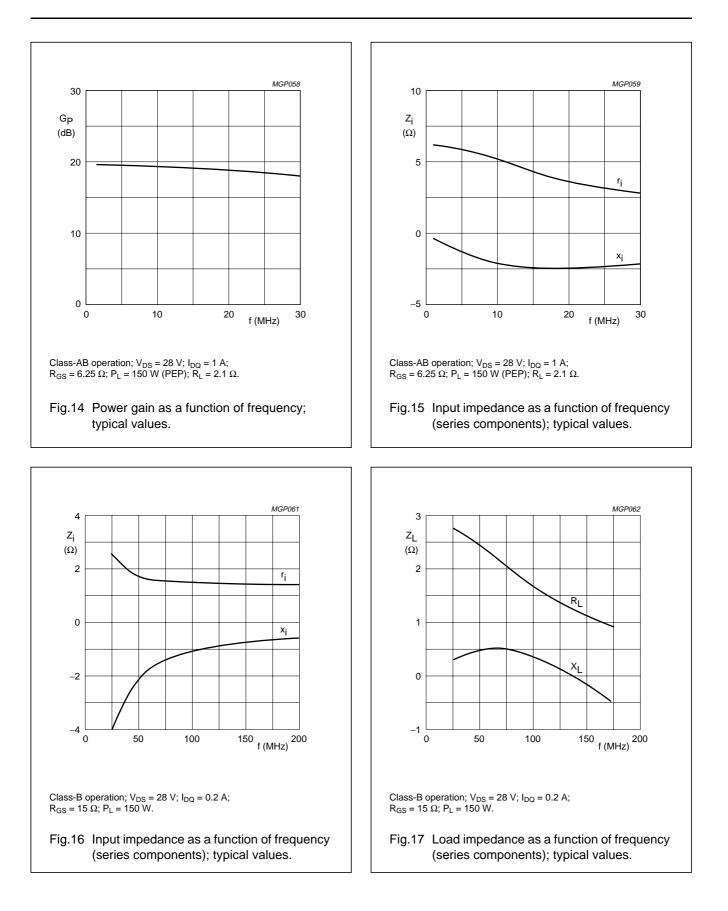
COMPONENT	DESCRIPTION	VALUE	DIMENSIONS	CATALOGUE NO.
C1, C3, C13, C14	film dielectric trimmer	7 to 100 pF		2222 809 07015
C2, C8, C9	multilayer ceramic chip capacitor; note 1	75 pF		
C4, C5	multilayer ceramic chip capacitor	100 nF		2222 852 47104
C6	multilayer ceramic chip capacitors in parallel	3×100 nF		2222 852 47104
C7	electrolytic capacitor	2.2 μF, 63 V		
C10	multilayer ceramic chip capacitor; note 1	100 pF		
C11, C12	multilayer ceramic chip capacitor; note 1	150 pF		
C15	multilayer ceramic chip capacitor; note 1	240 pF		
L1	6 turns enamelled 0.7 mm copper wire	145 nH	length 5 mm; int. dia. 6 mm; leads 2×5 mm	
L2, L3	stripline; note 2	41.1 Ω	length 13 × 6 mm	
L4	4 turns enamelled 1.5 mm copper wire	148 nH	length 8 mm; int. dia. 10 mm; leads 2×5 mm	
L5, L6	grade 3B Ferroxcube wideband HF choke			4312 020 36642
L7	3 turns enamelled 2.2 mm copper wire	79 nH	length 8 mm; int. dia. 8 mm; leads 2 × 5 mm	
R1, R2	1 W metal film resistor	19.6 Ω		2322 153 51969
R3	0.4 W metal film resistor	10 kΩ		2322 151 71003
R4	0.4 W metal film resistor	1 MΩ		2322 151 71005
R5	1 W metal film resistor	10 Ω		2322 153 51009

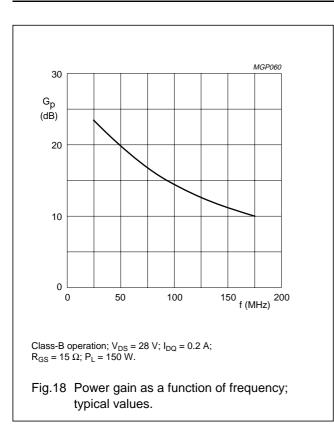
List of components (see Fig 13).

Notes

1. American Technical Ceramics (ATC) capacitor, type 100B or other capacitor of the same quality.

2. The striplines are on a double copper-clad printed circuit board, with PTFE fibre-glass dielectric (ϵ_r = 2.2), thickness 1.6 mm.





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BLF147 scattering parameters

 $V_{DS} = 28 \text{ V}; I_D = 1000 \text{ mA}; \text{ note } 1$

f (MHz)		s ₁₁	S	21	S	12	ę	22
	s ₁₁	$\angle \Phi$	s ₂₁	$\angle \Phi$	s ₁₂	$\angle \Phi$	s ₂₂	$\angle \Phi$
5	0.91	-170.00	23.90	93.40	0.01	5.80	0.88	-171.20
10	0.91	-174.60	12.25	89.40	0.01	3.60	0.89	-177.20
20	0.92	-177.40	5.94	81.00	0.01	5.40	0.83	-179.60
30	0.92	-178.40	3.87	79.10	0.01	8.90	0.86	-178.90
40	0.92	-178.80	2.84	75.70	0.01	12.00	0.85	-178.60
50	0.92	-178.80	2.26	73.30	0.01	16.90	0.87	-176.90
60	0.92	-179.00	1.88	69.80	0.01	20.30	0.90	-177.30
70	0.93	-179.20	1.58	66.20	0.01	24.00	0.90	-178.10
80	0.93	-179.60	1.36	63.20	0.01	28.80	0.90	-178.40
90	0.93	-179.70	1.19	60.40	0.01	34.20	0.90	-178.60
100	0.94	-179.70	1.05	57.00	0.01	39.30	0.90	-179.40
125	0.95	179.50	0.77	49.30	0.01	52.30	0.88	179.20
150	0.95	179.00	0.60	45.80	0.01	64.90	0.91	-179.50
175	0.96	178.10	0.49	41.50	0.02	72.40	0.95	179.80
200	0.96	177.50	0.40	36.80	0.02	75.80	0.94	177.70
250	0.97	175.80	0.28	33.20	0.03	82.30	0.95	176.20
300	0.98	174.20	0.22	30.10	0.03	83.00	0.96	173.60
350	0.98	172.70	0.17	31.00	0.04	85.00	0.97	171.90
400	0.98	171.10	0.14	32.40	0.05	84.90	0.97	169.50
450	0.98	169.50	0.12	36.10	0.05	85.90	0.97	167.70
500	0.98	167.90	0.11	39.90	0.06	84.30	0.98	165.50
600	0.98	164.80	0.10	50.20	0.07	83.20	0.97	161.50
700	0.98	161.60	0.10	57.90	0.09	81.70	0.97	157.50
800	0.98	158.20	0.11	63.70	0.10	81.00	0.97	153.50
900	0.97	154.60	0.13	67.20	0.12	79.50	0.97	149.30
1000	0.97	151.10	0.14	70.20	0.14	78.80	0.96	144.90

Note

1. For more extensive S-parameters see internet:

http://www.semiconductors.philips.com/markets/communications/wirelesscommunications/broadcast.

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			↑ A ↓				- D				↓ F •						
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IMENS	SIONS (I	millimet	tre dime	H	are der	ived fro	om the c	priginal				100 A (5			
	SIONS (I	b	tre dime	H	are der	ived fro F	н	priginal				1(M) A (k		5			
				H	D ₁ 12.83				inch din	mension	ns)		0	5 scale	10 n	nm α	
UNIT mm	A 7.27	b 5.82 5.56 0.229	c 0.16 0.10 0.006	H H D 12.86	D ₁ 12.83 12.57 0.505	F 2.67 2.41 0.105	H 28.45 25.52 1.120	p 3.30	inch din Q 4.45	nension	ns) U1 24.90	U ₂	0 U3 12.32 12.06 0.485	5 scale	10 n	nm	
UNIT mm inches	A 7.27 6.17 0.286 0.243	b 5.82 5.56 0.229 0.219	c 0.16 0.10 0.006	H H 12.86 12.59 0.506	D ₁ 12.83 12.57 0.505	F 2.67 2.41 0.105	H 28.45 25.52 1.120 1.005	p 3.30 3.05 0.130 0.120	inch dii Q 4.45 3.91 0.175 0.154	nension q 18.42	ns) U1 24.90 24.63 0.98	U ₂ 6.48 6.22 0.255	0 U 3 12.32 12.06 0.485	5 scale w1 0.25 0.01	10 n • • • • • • • • • • • • • • • • • • •	nm α	
UNIT mm inches	A 7.27 6.17 0.286	b 5.82 5.56 0.229 0.219	c 0.16 0.10 0.006 0.004	H H 12.86 12.59 0.506	D ₁ 12.83 12.57 0.505	F 2.67 2.41 0.105	H 28.45 25.52 1.120 1.005 REFE	p 3.30 3.05 0.130	inch dii Q 4.45 3.91 0.175 0.154	nension q 18.42	ns) U1 24.90 24.63 0.98	U ₂ 6.48 6.22 0.255	0 U3 12.32 12.06 0.485 0.475	5 scale w1 0.25 0.01	10 n 	nm α 45°	

PACKAGE OUTLINE

VHF power MOS transistor

Legal information

Data sheet status

Document status[1][2]	Product status ^[3]	Definition
Objective [short] data sheet	Development	This document contains data from the objective specification for product development.
Preliminary [short] data sheet	Qualification	This document contains data from the preliminary specification.
Product [short] data sheet	Production	This document contains the product specification.

[1] Please consult the most recently issued document before initiating or completing a design.

[2] The term 'short data sheet' is explained in section "Definitions".

[3] The product status of device(s) described in this document may have changed since this document was published and may differ in case of multiple devices. The latest product status information is available on the Internet at URL http://www.nxp.com.

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Revision history

Revision history				
Document ID	Release date	Data sheet status	Change notice	Supersedes
BLF147_6	20061205	Product data sheet	-	BLF147_5
Modifications:	 Correction m 	ade to page 9 "List of compor	ients"	
BLF147_5	20061108	Product data sheet	-	BLF147_4
BLF147_4 (9397 750 11593)	20030901	Product specification	-	BLF147_3
BLF147_3 (9397 750 08411)	20010523	Product specification	-	BLF147_CNV_2
BLF147_CNV_2 (9397 750 xxxxx)	19971215	Product specification	-	-

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Date of release: 5 December 2006 Document identifier: BLF147_6



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